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(Not for submission under 37 CFR 1.99)	i

Application Number		10517575		
Filing Date		2004-12-09		
First Named Inventor	Victor	Lu		
Art Unit		2813		
Examiner Name	Monic	a D. Harrison		
Attorney Docket Number		H0004019.68746 US - 4780		

	U.S.PATENTS								
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	2	4299938		1981-11-10	Ciba-Geigy Corporation				
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	7	4910122		1999-03-20	Brewer Science, Inc.				
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	1	20060110682	A1	2006-05-25		Shipley Compa	any, L.L.C.			
	2	20060155594	A1	2006-07	'-13	Jess Almeida,	et al.			
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4	YC. Lin et al., "Some Aspects of Anti-Reflective Coating for Optical Lithography," Advances in Resist Technology and Processing, Proc., SPIE vol. 469, 30-37 (1984).	
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